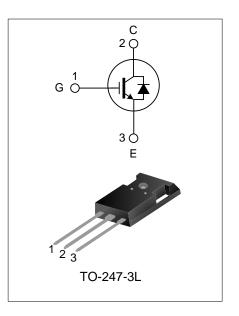
## 75A, 650V FIELD STOP IGBT

#### **DESCRIPTION**

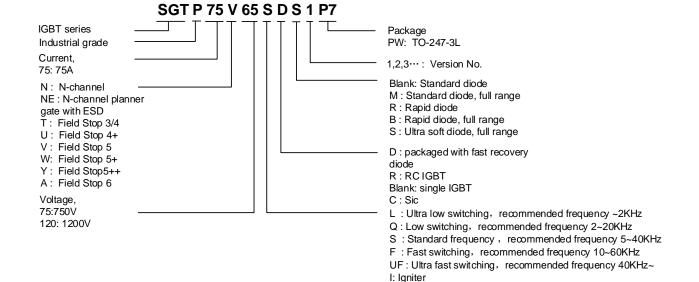
The SGTP75V65SDS1P7 field stop IGBT adopts Silan Field Stop V technology, features low conduction loss and switching loss. This device is applicable to photovoltaic, UPS, SMPS, and PFC fields.

### **FEATURES**

- 75A, 650V, V<sub>CE(sat)(typ.)</sub>=1.42V@I<sub>C</sub>=75A
- Low conduction loss
- Ultra-fast switching
- High input impedance
- T<sub>Jmax.</sub>=175°C



#### **NOMENCLATURE**



### **ORDERING INFORMATION**

Part No.	Package	Marking Hazardous Substance Control		Packing Type	
SGTP75V65SDS1P7	TO-247-3L	P75V65SDS1	Halogen free	Tube	

Rev.:1.2 http://www.silan.com.cn Page 1 of 12



## ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, Tc=25°C)

Characteristics		Symbol	Ratings	Unit
Collector - Emitter Voltage		V <sub>CE</sub>	650	٧
Gate - Emitter Voltage		$V_{GE}$	±20	٧
Transient Gate - Emitter Voltage (t <sub>p</sub> ≤10μs, D<0.010)		$V_{GE}$	±30	٧
Collector Current	T <sub>C</sub> =25°C		150	A
Collector Current	T <sub>C</sub> =100°C	I <sub>C</sub>	75	A
Pulsed Collector Current		I <sub>CM</sub>	300	Α
Diode Current	T <sub>C</sub> =25°C		150	A
	T <sub>C</sub> =100°C	I <sub>F</sub>	75	A
Diode Pulsed Current		I <sub>FM</sub>	300	Α
Power Dissipation (T <sub>C</sub> =25°C)		P <sub>tot</sub>	395	W
Operating Junction Temperature		TJ	-40∼+175	°C
Storage Temperature Range		T <sub>stg</sub>	-55∼+150	°C

### THERMAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Тур.	Max.	Unit
Thermal Resistance, Junction to Case (IGBT)	R <sub>th(j-C)</sub>				0.38	°C/W
Thermal Resistance, Junction to Case (FRD)	R <sub>th(j-C)</sub>				0.6	°C/W
Thermal Resistance, Junction to Ambient (IGBT)	R <sub>th(j-a)</sub>				40	°C/W
Soldering Temperature (in line)	T <sub>sold</sub>	15 <sup>+2</sup> <sub>-0</sub> sec, 1time			260	°C

http://www.silan.com.cn Page 2 of 12



### ELECTRICAL CHARACTERISTICS OF IGBT (UNLESS OTHERWISE NOTED, TJ=25°C)

Characteristics	Symbol	Test conditions	Min.	Тур.	Max.	Unit
Collector- emitter Breakdown Voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V, I <sub>C</sub> =250μA	650			V
Zero Gate Voltage Collector Current	I <sub>CES</sub>	V <sub>CE</sub> =650V, V <sub>GE</sub> =0V			50	μA
Gate-emitter Leakage Current	I <sub>GES</sub>	V <sub>GE</sub> =20V, V <sub>CE</sub> =0V			±100	nA
Gate-emitter Threshold Voltage	$V_{GE(th)}$	$I_C=250\mu A,\ V_{CE}=V_{GE}$	3.4	4.0	5.0	V
Collector emitter Seturation Valtage	V	I <sub>C</sub> =75A, V <sub>GE</sub> =15V, T <sub>J</sub> =25°C		1.42	1.85	V
Collector-emitter Saturation Voltage	$V_{CEsat}$	I <sub>C</sub> =75A, V <sub>GE</sub> =15V, T <sub>J</sub> =175°C		1.76		V
Input Capacitance	Cies	V <sub>CE</sub> =30V		4914		
Output Capacitance	C <sub>oes</sub>	V <sub>GE</sub> =0V		182		pF
Reverse Transfer Capacitance	C <sub>res</sub>	f=1MHz		20		
Turn-On Delay Time	T <sub>d(on)</sub>	$\begin{array}{lll} & V_{\text{CE}}\text{=}400\text{V} \\ & I_{\text{C}}\text{=}75\text{A} \\ & R_{g}\text{=}10\Omega \\ & V_{\text{GE}}\text{=}15\text{V} \\ & \text{inductive load} \\ & T_{\text{J}}\text{=}25^{\circ}\text{C} \end{array}$		36		ns
Rise Time	Tr			63		
Turn-Off Delay Time	$T_{d(off)}$			218		
Fall Time	T <sub>f</sub>			71		
Turn-on Energy	E <sub>on</sub>			1.06		mJ
Turn-off Energy	E <sub>off</sub>			1.10		
Total Switching Energy	E <sub>st</sub>	- TJ=25 C		2.26		
Turn-On Delay Time	$T_{d(on)}$	$V_{CE}=400V$ $I_{C}=37.5A$ $R_{g}=10\Omega$		31		ns
Rise Time	T <sub>r</sub>			25		
Turn-Off Delay Time	$T_{d(off)}$			221		
Fall Time	T <sub>f</sub>			39		
Turn-on Energy	Eon	V <sub>GE</sub> =15V inductive load		0.48		
Turn-off Energy	E <sub>off</sub>	T <sub>J</sub> =25°C		0.57		mJ
Total Switching Energy	E <sub>st</sub>	7 11-20 0		1.05		
Total Gate Charge	Qg			181		nC
Gate to Emitter Charge	$Q_ge$	V <sub>CE</sub> =520V, I <sub>C</sub> =75A, V <sub>GE</sub> =15V		38		
Gate to Collector Charge	Q <sub>gc</sub>	<u></u>		48		

## ELECTRICAL CHARACTERISTICS OF FRD (UNLESS OTHERWISE NOTED, T<sub>J</sub>=25°C)

Characteristics	Symbol	Test conditions	Min.	Тур.	Max.	Unit
Diode Forward Voltage	V <sub>F</sub>	I <sub>F</sub> =75A, T <sub>J</sub> =25°C		1.65	2.0	V
		I <sub>F</sub> =75A, T <sub>J</sub> =175°C		1.55		
Diode Reverse Recovery Time	T <sub>rr</sub>	1 75 dl /dt 200 ///		61		ns
Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>ES</sub> =75A, dI <sub>ES</sub> /dt=200A/μs,		0.20		nC
Diode Reverse Recovery Current	Irrm	T <sub>J</sub> =25°C		6.3		А

Rev.:1.2



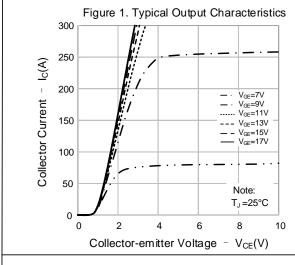
## ELECTRICAL CHARACTERISTICS OF IGBT (UNLESS OTHERWISE NOTED, TJ=150°C)

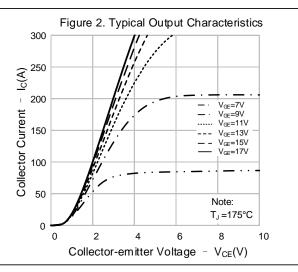
Characteristics	Symbol	Test conditions	Min.	Тур.	Max.	Unit
Turn-On Delay Time	T <sub>d(on)</sub>	1001		38		
Rise Time	Tr	V <sub>CE</sub> =400V		52		20
Turn-Off Delay Time	T <sub>d(off)</sub>	I <sub>C</sub> =75A		235		ns
Fall Time	T <sub>f</sub>	$R_g=10\Omega$		74		
Turn-on Energy	Eon	V <sub>GE</sub> =15V inductive load		1.44		
Turn-off Energy	E <sub>off</sub>	T <sub>.i</sub> =150°C		1.60		mJ
Total Switching Energy	E <sub>st</sub>			3.04		
Turn-On Delay Time	T <sub>d(on)</sub>	14 4001/		34		
Rise Time	Tr	V <sub>CE</sub> =400V		30		20
Turn-Off Delay Time	T <sub>d(off)</sub>	$I_{C}$ =37.5A $R_{g}$ =10 $\Omega$ $V_{GE}$ =15 $V$ inductive load		246		ns
Fall Time	T <sub>f</sub>			72		
Turn-on Energy	Eon			0.60		
Turn-off Energy	E <sub>off</sub>	T <sub>J</sub> =150°C		0.86		mJ
Total Switching Energy	E <sub>st</sub>	1J=150°C		1.46		

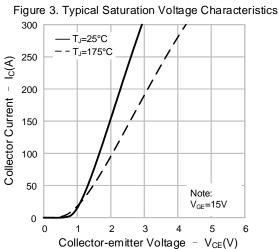
Rev.:1.2 Page 4 of 12

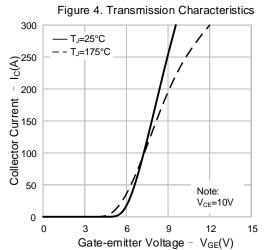


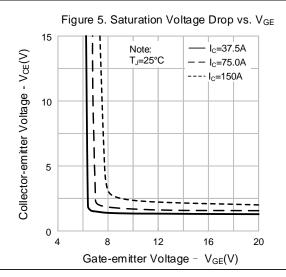
#### TYPICAL CHARACTERISTICS

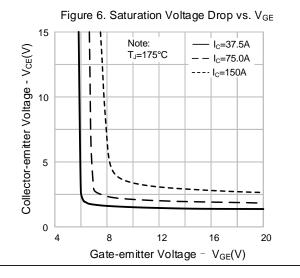






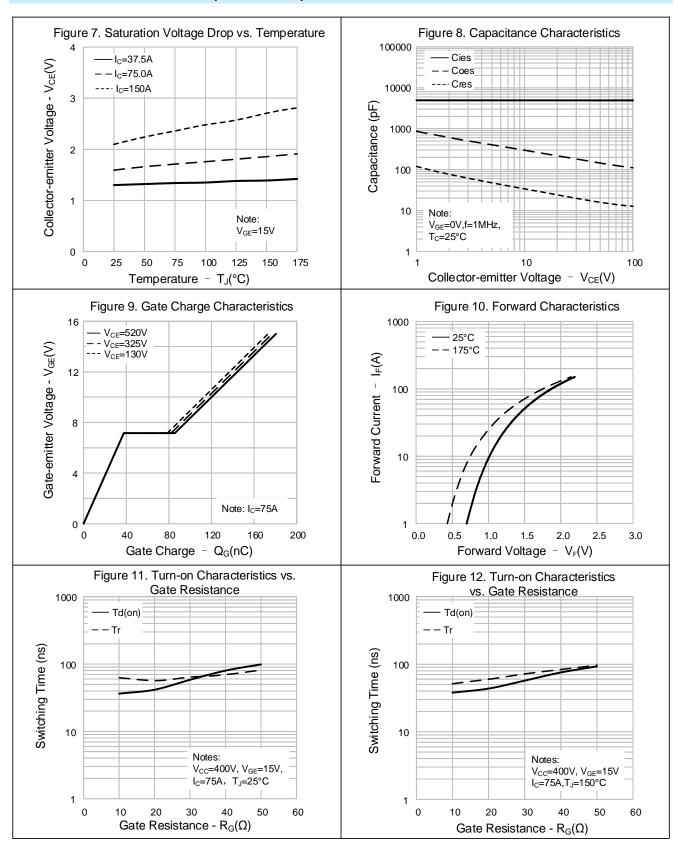






Rev.:1.2 http://www.silan.com.cn Page 5 of 12

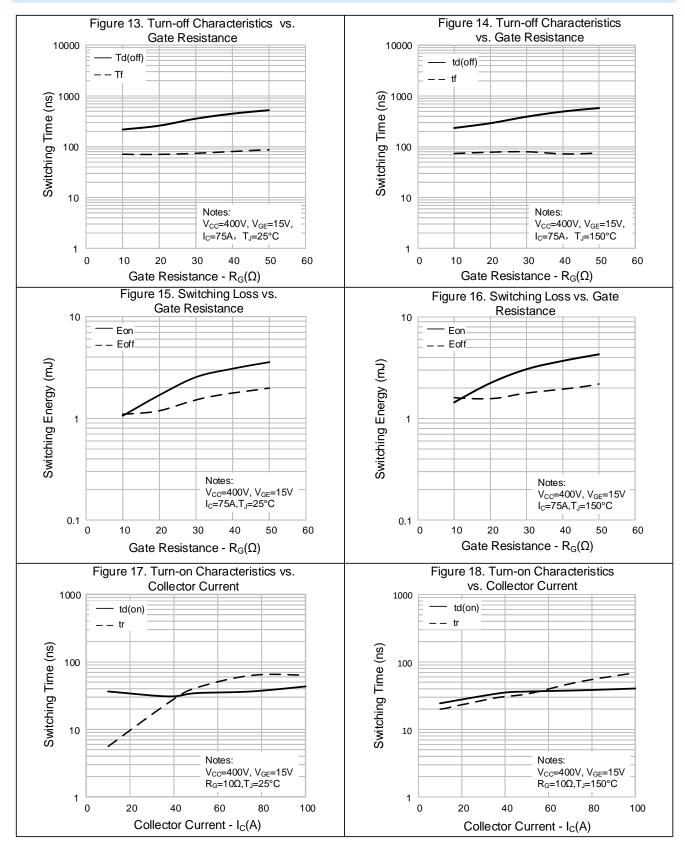




Rev.:1.2

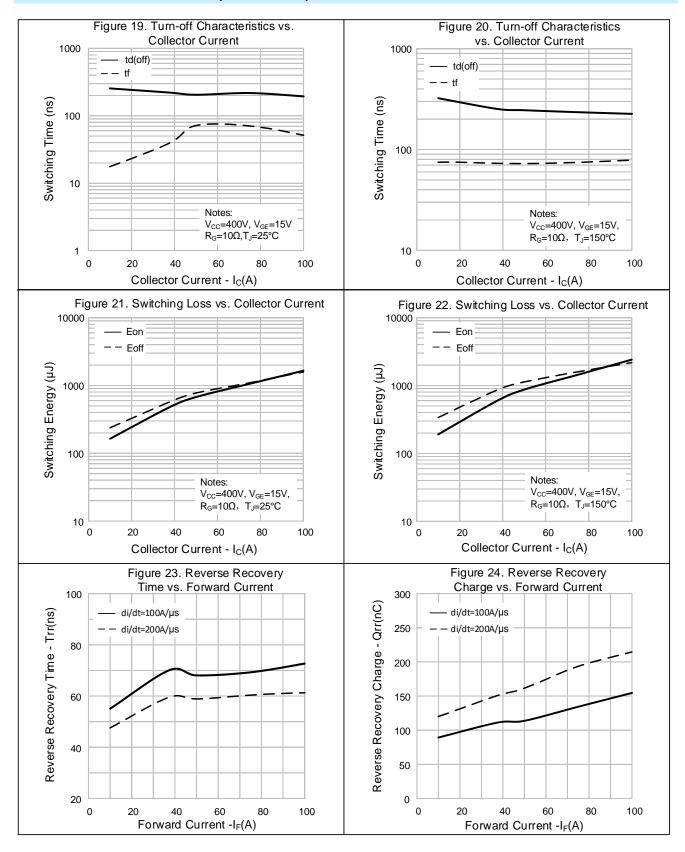






Rev.:1.2 Page 7 of 12

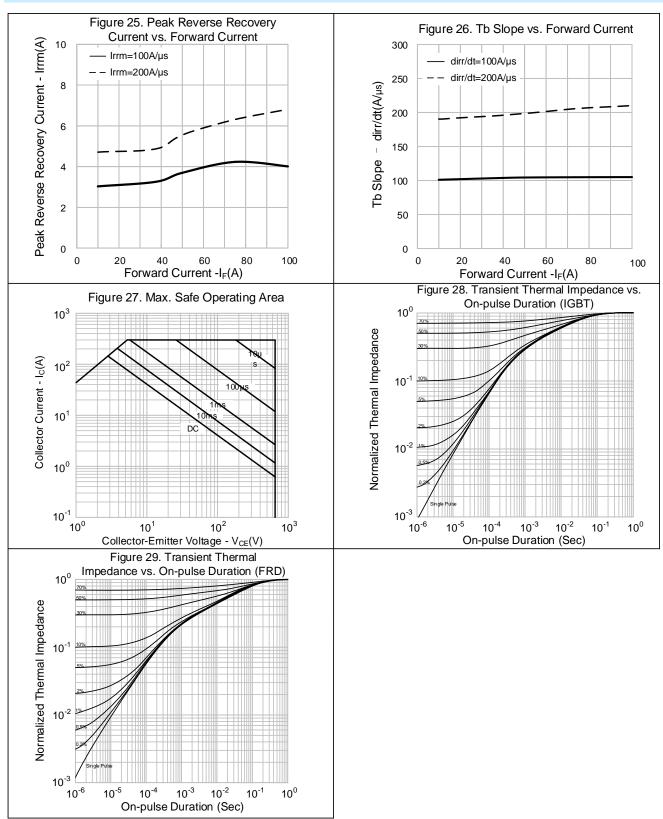




Rev.:1.2



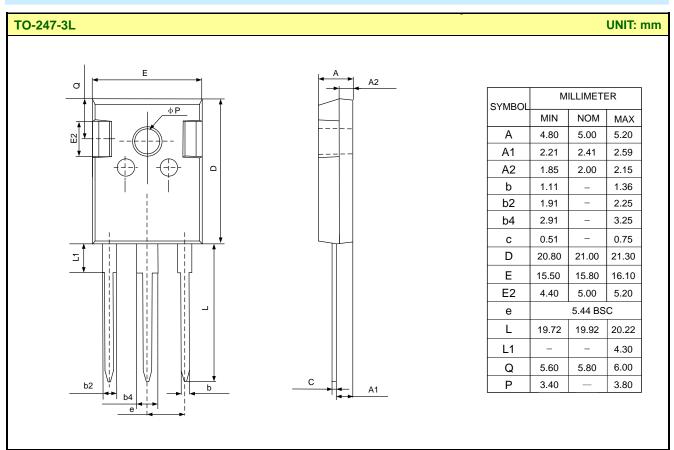




Rev.:1.2



### **PACKAGE OUTLINE**





### **IGBT DEVICES OPERATE NOTES:**

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the IGBT electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- IGBT devices should be packed in antistatic/conductive containers for transportation.

Rev.:1.2



#### Important notice:

- Silan reserves the right to make changes of this instruction without notice.
- 2. Customers should obtain the latest relevant information when purchasing and should verify whether such information is latest and complete. Please read this instruction and application manual and related materials carefully before using products, including the circuit operation precautions, etc.
- It is neither tested nor verified in accordance with AEC-Q series standards testing or application requirements. Silan does not give any warranties as to the suitability of the Silan's product for any specific use. The design intent, design definition and design of the product are not intended for application (the application stated in this instruction includes use, etc.) in transportation equipment, medical equipment, life-saving equipment, aerospace equipment, non-civil equipment or non-civil use, etc. (the equipment stated in this instruction includes systems, devices, etc., all referred to as equipment). The product should not be used in any equipment or system whose manufacture, use or sale is prohibited under any applicable laws or regulations("unintended use"). If the product is used for unintended use, therefore the full risks of such products application are borne by the customer and Silan assumes no liability for the product used for the unintended use. If the customer intends to use the Silan's product in a application where malfunction or failure can be reasonably be expected to result in personal injury, or serious property, or environment damage, the customer shall make adequate assessment, testing and verification, and Silan shall not be liable for such applications.
- The application of the product described in this instruction, the application manual of the product and related materials is for illustrative purposes only, and Silan makes no warranty that such application can be used directly without further testing, verification or modification. Silan is not responsible for any assistance in product application or customers' product design. Customer shall be responsible for the application of Silan's products and the design, manufacture and use of customers' products using Silan's products (in this document, "use products", "apply Silan's products", "product application" and "customers' products using Silan's products" are synonymous). It is the sole responsibility of the customer to take the following actions: 1) Verify and determine whether Silan's products are suitable for the customers' applications and customers' products; 2) All applicable standards of the customers' industry shall be complied with and fully tested and verified when applying Silan's product or using Silan's product to develop and design customers' products; 3) Although Silan is constantly committed to improve product's quality and reliability, semiconductor products have possibility to malfunction or fail in various application environments. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for customers' products using Silan's product to minimize risks and avoid situations in which a malfunction or failure could cause bodily injury or damage to property; 4) When using the products, please do not exceed the maximum rating of the products, Stress above one or more limiting values will cause damage to the product and the equipment or affect the reliability to the equipment (customers' product); 5) Ensure customers' product using Silan's product are designed, manufactured and used in full compliance with all applicable standards, safety standards and other requirements of the customers' industry. The parameters stated in this instruction may and do vary in different applications, actual performance may vary over time. Customers must use the products within their effective static storage period, please contact Silan sales or Silan customer service support and sales management department if there is any questions about the effective static storage period, Silan does not assume any responsibility if the product has exceeded the static storage period when it
- 5. Do not disassemble, reverse-engineer, alter, modify, decompile or copy product, without Silan's prior written consent.
- Please identify Silan's trademark when purchasing our product. Please contact us if there is any question. Our products are not sold through TAOBAO or any other third-party e-commerce platforms. If customers purchase from such platforms, please contact us in writing before purchasing to confirm whether the product is authentic and original from Silan.
- Please use and apply product in compliance with all applicable laws and regulations, including but not limited to trade control 7. regulations etc. The product is civil electronic product, please do not use it in non-civil fields.
- Product promotion is endless, our company will wholeheartedly provide customers with better products! 8.
- 9. Website: http://www.silan.com.cn

Rev.:1.2



Part No.: SGTP75V65SDS1P7 Document Type: Datasheet

Copyright: HANGZHOU SILAN MICROELECTRONICS CO.,LTD Website: http://www.silan.com.cn

Rev.: 1.2

Revision History:

1. Update nomenclature and parameter names

2. Update the important notice

Rev.: 1.

Revision History:

1. Modify  $P_D$  and  $R_{\theta JC}$  and update corresponding typical characteristics

2. Update the important notice

Rev.: 1.0

Revision History:

1. First release

HANGZHOU SILAN MICROELECTRONICS CO.,LTD

http://www.silan.com.cn Page 12 of 12